

<b>Notice of References Cited</b>	Application/Control No. 10/766,185		Applicant(s)/Patent Under Reexamination YOON ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0096848	05-2004	Thrue et al.	435/006
*	B	US-2004/0220393	11-2004	Ward et al.	536/023.1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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